

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

214503US0

SERIAL NO.

09/964,622

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Toshiki NANYA, et al.

FILING DATE

September 28, 2001

GROUP

1756

DEC 26 2001

PATENT &amp; TRADEMARK OFFICE

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
CR	AA	5,882,832	03/16/99	Tosaka et al.			
CR	AB	5,225,303	07/06/93	Tomita et al.			
CR	AC	5,168,028	12/01/92	Nanya et al.			
CR	AD	5,079,123	01/07/92	Nanya et al.			
CR	AE	5,102,766	04/07/92	Nanya et al.			
CR	AF	5,085,965	02/04/92	Nanya et al.			
CR	AG	4,980,258	12/25/90	Aoki et al.			
CR	AH	4,990,425	02/05/91	Nanya et al.			
CR	AI	6,303,258	10/16/01	Katoh et al.			
CR	AJ	6,183,926	02/06/01	Kuroda et al.			
CR	AK	6,103,441	08/15/00	Tomita et al.			
CR	AL	6,074,794	06/13/00	Fushimi et al.			
CR	AM	6,004,715	12/21/99	Suzuki et al.			
CR	AN	5,879,849	03/09/99	Sawada et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
CR	AO	63-088564	04/19/88	JAPAN w/English Abstract		
CR	AP	63-184762	07/03/88	JAPAN w/English Abstract		
CR	AQ	03-056974	03/12/91	JAPAN w/English Abstract		
CR	AR	06-230609	08/19/94	JAPAN w/English Abstract		
CR	AS	08-030017	02/02/96	JAPAN w/English Abstract		
CR	AT	09-171271	06/30/97	JAPAN w/English Abstract		
CR	AU	09-211896	08/15/97	JAPAN w/English Abstract		
CR	AV	11-218965	08/10/99	JAPAN w/English Abstract		

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
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☐ Additional References sheet(s) attached

Examiner

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>SP</i>	AA	5,851,716	12/22/98	Kuramoto et al.			
<i>SP</i>	AB	5,061,588	10/29/91	Fushimi et al.			
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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Toshiki NANYA		RECEIVED MAY 28 2002 TC 1700	
				FILING DATE September 28, 2001			
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CDR	AA	5,288,577	2-22-1994	Yamaguchi et al.			
CDR	AB	5,368,972	11-29-1994	Yamashita et al.			
CDR	AC	5,429,901	7-4-1995	Muto et al.			
CDR	AD	6,010,814	1-4-2000	Kotsugai et al.			
CDR	AE	6,180,298	1-30-01	Kuroda et al.			
CDR	AF	6,074,795	6-13-2000	Watanabe et al.			
CDR	AG	6,228,550	5-8-2001	Matsuda et al.			
CDR	AH	6,258,502	7-10-2001	Nakamura et al.			
CDR	AI	6,303,257	10-16-2001	Hasegawa et al.			
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
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Examiner <u>CDR</u>					Date Considered <u>10/28/02</u>		
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DR	AA	5,597,673	01/28/97	WATANABE, et al.			
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CR	AA	5,840,456	11/24/98	TOMITA, et al.			
CR	AB	5,721,083	02/24/98	MASUDA, et al.			
CR	AC	5,554,478	09/10/96	KURAMOTO, et al.			
CR	AD	5,403,690	04/04/95	KURAMOTO, et al.			
CR	AE	5,344,732	09/06/94	CHIBA, et al.			
CR	AF	4,933,250	06/12/90	NAKAYAMA, et al.			
CR	AG	4,950,573	08/21/90	YAMAGUCHI, et al.			
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GD	AA	6,406,826	06/18/02	SUZUKI, et al.			
GR	AB	6,363,229	03/26/02	SHIRAISHI, et al.			
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